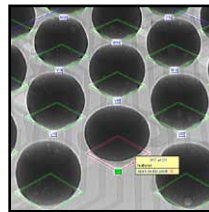
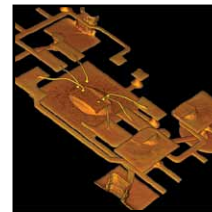


phoenix microme|x DXR-HD

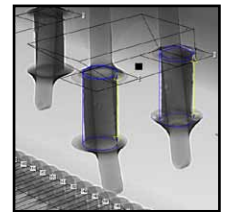
High resolution 180 kV microfocus X-ray system for CAD based 2D μ AXI of solder joints and electronic components with 3D CT option



Open BGA ball with live CAD data overlay



3D Computed Tomography of a ceramic SMD IC



Automated PTH solder joint inspection with live CAD data overlay

Unique features

- Temperature stabilized digital DXR detector with active cooling for high dynamic live imaging
- 180 kV / 20 W high-power submicron tube with up to 0.5 μ m detail detectability
- x|act package for CAD based μ AXI programming and automatic inspection
- diamond|window for up to 2 times faster data acquisition at the same high image quality level as a new standard
- Optionally 3D computed tomography scans within 10 seconds



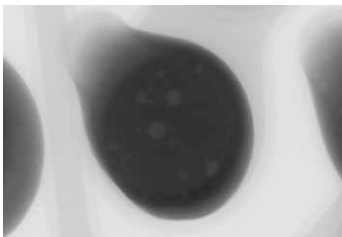
GE imagination at work

phoenix microme|x DXR-HD

The high performance X-ray inspection solution

The phoenix microme|x DXR-HD combines high-resolution 2D X-ray technology and computed tomography in one system. Innovative and unique features and an extreme high positioning accuracy make the system the effective and reliable solution for a wide spectrum of 2D and 3D inspection tasks: R&D, failure analysis, process and quality control as well as automated offline inspection. The phoenix|x-ray x|act technology offers easy to program CAD based μ AXI ensuring automated inspection in the micrometer range. Another unique benefit is GE's highly dynamic DXR flat panel detector with active cooling. Offering up to 30 frames per second, it provides outstanding brilliant live imaging and fast data acquisition for 3D CT.

Brilliant DXR-HD live imaging



Voids in a single BGA ball: 1,970x geometric zoom for extreme high magnification

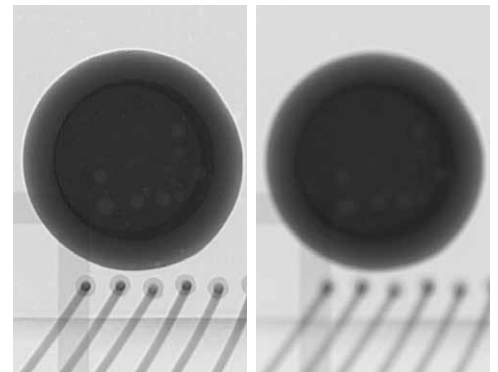
With GE's proprietary high dynamic DXR detector with enhanced scintillator technology phoenix|x-ray introduces a new industry standard for efficient live inspection:

- Full frame rate of 30 frames per second at 1000x1000 pixels offers low noise coupled with brilliant image quality ensuring fast and detailed live inspection
- Active temperature stabilization for precise and reliable inspection results
- Extremely fast data acquisition in 3D CT mode
- Detail detectability down to 0.5 μ m for high performance failure analysis

High output with high-resolution: diamond|window

Compared to conventional beryllium targets, the diamond|window of the microme|x DXR-HD allows higher power at a smaller focal spot. This ensures high-resolution even at a high output.

- Up to 2 times faster CT data acquisition at the same high image quality level
- High output with high-resolution
- Non-toxic target
- Improved focal spot position stability within long term measurements
- Increased target lifetime due to less degradation with higher power density

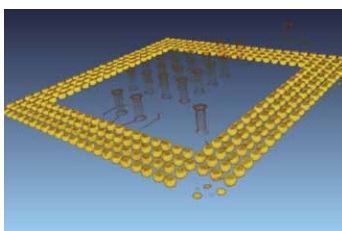


diamond|window beryllium window
(same X-ray tube parameter: 130 kV, 11.4 W)

High-resolution 3D computed tomography

For advanced inspection and three-dimensional analysis of smaller samples, phoenix|x-ray's proprietary 3D-CT technology is available as an add-on for the microme|x DXR-HD.

- 180 kV high power X-ray technology, fast image acquisition with DXR detector and diamond window combined with phoenix|x-ray's fast reconstruction software deliver high quality inspection results
- Performing of 3D CT scans within just 10 seconds
- Maximum voxel resolution down to 2 microns, depending on the sample size



Separated 3D CT image of a POP-layer with not well joined balls

x|act pro - CAD based inspection:

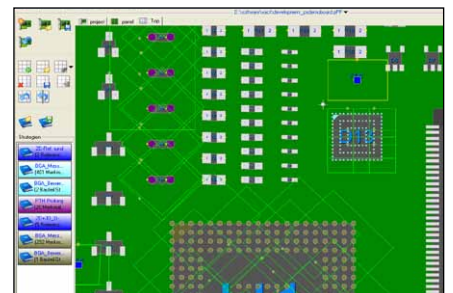
high resolution μ AXI for extremely high defect coverage

As a solution for μ AXI with extremely high defect coverage, phoenix|x-ray provides its high precision system micromex DXR-HD including the unique x|act pro software package for fast and easy offline CAD programming. Outstanding precision and repeatability, small views with resolutions of only a few micrometers, 360° rotation and oblique viewing up to 70° ensures meeting highest quality standards - even for inspection of components with a pitch of just 100 microns. Besides the automated X-ray inspection, x|act pro ensures an easy pad identification by its live CAD data overlay function even in manual inspection.

Efficient CAD programming – minimized setup time

x|act pro provides not only a minimal setup time compared with conventional view based AXI - once programmed, the inspection program is portable to all x|act compatible systems.

- Import of CAD-data
- Easy pad-based offline programming
- Specific inspection strategies for different pad types
- Fully automated generation of the inspection program even in oblique view and multiple angular positions per component
- Full program portability for all x|act compatible phoenix|x-ray systems



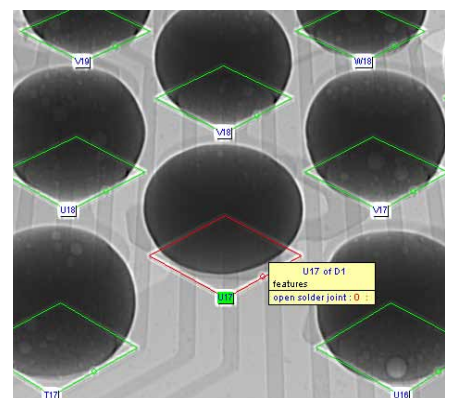
Fast and easy programming: just assign the inspection strategies and let x|act generate the automated inspection program

Repeatably high defect coverage

- Extremely high positioning accuracy even at oblique viewing and rotation
- Easy pad identification in manual X-ray inspection
- High reproducibility on large PCBs

phoenix micromex HD – Your Advantages

- Brilliant live inspection images due to high dynamic GE DXR digital detector array
- Unique 180 kV / 20 W high power submicron tube for high absorbing samples
- Minimized setup time due to highly efficient automated CAD programming
- Live overlay of CAD and inspection results even in rotated oblique inspection views
- Extremely high defect coverage and repeatability
- Outstanding ease-of-use
- Detail detectability down to 0.5 μ m
- Inspection results and images include correct pad numbering for easy rework
- Optionally advanced failure analysis with high resolution 3D Computed Tomography
- Optionally CT scans up to 10 seconds



x|act provides live CAD overlay and inspection results in the x-ray live image - at any time, at any viewing angle

Technical Specifications & Configurations

System magnification and resolution

Geometric magnification:	max. 1,970 x
Total magnification:	max. 2,660 x
Detail detectability:	up to 0,5 µm

180 kV microfocus X-ray tube

Type:	Low maintenance open microfocus tube with unlimited lifetime, transmission type, 170° cone angle, collimated
Maximal tube voltage	180 kV
Maximal tube output	20 W
Target:	non-toxic diamond window (tungsten on CVD support) for up to 2 times faster data acquisition at the same high image quality level
Filament:	Tungsten hairpin, pre-adjusted in plug-in cartridges for fast and easy exchange

High dynamic DXR detector

Type:	GE DXR250RT, temperature stabilized with active cooling for brilliant live imaging and extremely fast CT data acquisition
Pixels:	1000 x 1000 pixels
Resolution (pixel size):	200 x 200 micrometer
Frame grabbing rate:	Up to 30 fps at full frame

Precise manipulation

General construction:	high-precision vibration-free synchronised 5-axes manipulation
Max. inspection area:	460 mm x 360 mm (18" x 14") 610 mm x 510 mm (24" x 20") without rotation table 680 mm x 635 mm (27" x 25")/ 10 kg (22 lbs.)
Max. sample size/weight:	680 mm x 635 mm (27" x 25")/ 10 kg (22 lbs.)
ovhm – oblique view at highest magnification :	continuously adjustable view angle up to 70°, rotation 0° - 360°
Control:	Joystick or mouse control (manual mode) and CNC (automatic mode)
Manipulation aids:	sample X-ray mapping, click'n-move-to function, click'n-zoom-to function, automatic isocentric manipulator movement, laser crosshair
Anti-Collision System:	may be deactivated for maximum magnification (tube touching the sample)

System dimensions

Dimensions (W x H x D):	2,020 mm x 1,920 mm x 1,860 mm (79.5" x 75.6" x 73.2"); (D with console: 2,160 mm (85"))
Min. transportation width:	1,560 mm (61.4")
Weight:	appr. 2,600 kg / 5,732 lbs.

Radiation Protection

The radiation safety cabinet is a full protective installation without type approval according to the German RöV and the US Performance Standard 21 CFR 1020.40. For operation, other official licenses may be necessary.



Advanced image processing (16 bit)

x act pro:	comprehensive CAD based X-ray inspection software comprising image enhancement functions, measuring functions and fast and easy automated CAD based programming for automatic inspection
bg module (standard):	for automatic view based BGA solder-joint evaluation incl. automatic wetting analysis
vc module (standard):	automatic view based voiding calculation software package incl. capability of multiple die attach voiding evaluation

Software Configuration (Option)

x act BGA check strategy:	automated CAD based analysis of BGA solder joints
x act PTH check strategy:	automated CAD based analysis of PTH solder joints
qfp module:	automated QFP solder joint evaluation
qfn module:	automated inspection of QFN / MLF solder joints
pth module:	automated pin-through-hole solder joint evaluation
c4 module:	view based evaluation of round solder joints with background structure, such as C4 bumps
m module:	view based registration of multilayer printed circuit boards
quality review:	visual interface for rework and failure indication

Hardware Configuration (Option)

Tilt / rotate unit:	tilt ± 45° and rotation n x 360° for samples up to 2 kg
Manual bar code reader:	for product identification

Computed Tomography (Option)

Upgrade package for combined 2D / 3D (computed tomography) operation	
CT-unit:	precision rotation axis
Volume acquisition / reconstruction software:	phoenix datos x
Max. geom. magnification:	100 x (CT)
Max. voxel resolution:	down to 2 µm, depending on the sample size
Visualization software:	Volume Viewer



www.ge-mcs.com/phoenix



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